

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Name	Classification
	Α	US-6,064,084	05-2000	Tanahashi, Toru	257/296
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
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	κ	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Hisako Ono, et al. "Development of a planarized Al-Si contact filling technology"1990 Proc. 7th International IEEE VLSI Multilevel Interconnection Conf. pp76-82(1990)				
	٧	C. Yu, et al. "A novel submicron Al contact filling technology for ULSI metallization" 1991 Proc. 8th International IEEEVLSI multilevel Interconnection Conf., pp199-205 (1991).				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.